

Notice of References Cited	Application/Control No. 10/597,723	Applicant(s)/Patent Under Reexamination DUNKEL ET AL.	
	Examiner SHAIENDRA KUMAR	Art Unit 1621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,914,344 A	06-1999	Yoshikawa et al.	514/406
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	JP 2001-72510	03-2001	Japan	-	-
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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